Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/733,210	ALLEN ET AL.	
Examiner	Art Unit	
Paul Dinh	2825	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	1, 4-5, 7-11, 18	3/1/2005	PD
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARC (INCLUDING SE	CH NOTES ARCH STRATEGY)
	DATE	EXMR
EAST, IEEE	3/1/2005	PD